

Search Notes

Application/Control No.

10/763,010

Examiner

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Applicant(s)/Patent under
Reexamination

BREITSCHWERDT ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	711	3/15/2006	BT
438	728	3/15/2006	BT
438	732	3/15/2006	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	711	3/15/2006	BT
438	728	3/15/2006	BT
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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